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Application/Control No.	Applicant(s)/Patent under Reexamination
10/820,066	TAMAI ET AL.
Examiner	Art Unit
Usmaan Saeed	2166

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Class	Subclass	Date	Examiner
707	3	1/3/2007	US
707	1	1/3/2007	US
707	200	1/3/2007	US
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor & related case search	12/29/2006	US
East (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB)	10/17/2006	US
Consulted Primary Examiner (Khanh B. Pham)	1/3/2007	us
Plus	12/15/2007	US
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